

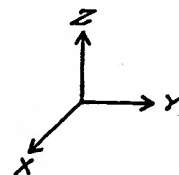
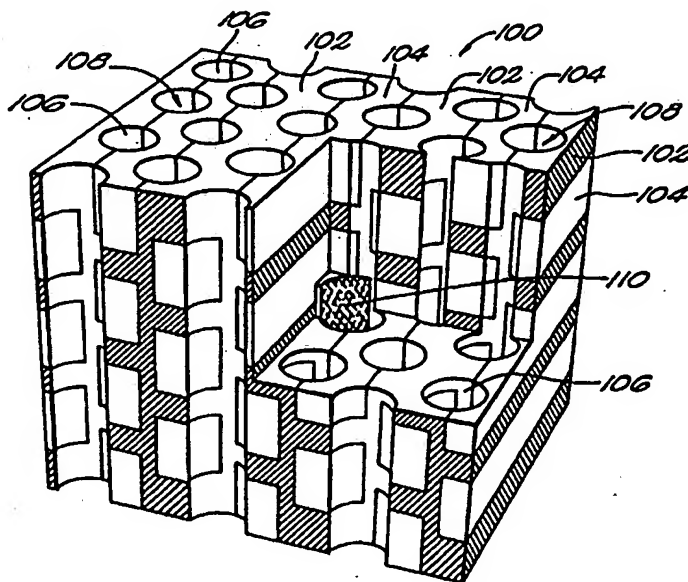
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(21) International Application Number: PCT/US97/22786 (22) International Filing Date: 12 December 1997 (12.12.97) (30) Priority Data: 60/032,723 13 December 1996 (13.12.96) US (71) Applicant: MASSACHUSETTS INSTITUTE OF TECHNOLOGY [US/US]; 77 Massachusetts Avenue, Cambridge, MA 02139 (US). (72) Inventors: JOANNOPOULOS, John, D.; 64 Douglas Road, Belmont, MA 02178 (US). VILLENEUVE, Pierre, R.; Apartment 407, 61 Brookline Avenue, Boston, MA 02215 (US). FAN, Shanhui; 881 Broadway, Somerville, MA 02144 (US). ABRAMS, Daniel, S.; Apartment 18C-2, 550 Memorial Drive, Cambridge, MA 02139 (US). (74) Agents: CONNORS, Matthew, E. et al.; Samuels, Gauthier, Stevens & Reppert, Suite 3300, 225 Franklin Street, Boston, MA 02110 (US).		(81) Designated States: CA, JP, European patent (AT, BE, CH, DE, DK, ES, FI, FR, GB, GR, IE, IT, LU, MC, NL, PT, SE). Published <i>With international search report.</i> <i>Before the expiration of the time limit for amending the claims and to be republished in the event of the receipt of amendments.</i>

(54) Title: TUNABLE MICROCAVITY USING NONLINEAR MATERIALS IN A PHOTONIC CRYSTAL**(57) Abstract**

A nonlinear dielectric material is incorporated within a photonic crystal as a means of changing the refractive index of a defect (110). In this way, the resonant frequency can be easily adjusted, after fabrication, by external mechanisms (either optical or electronic). The ability to tune the frequency of a resonant mode is useful for constructing photonic integrated devices, thus the invention enables the use of a photonic-crystal microcavity for such purposes. In one embodiment there is provided a photonic crystal (100) having a periodic dielectric structure, and a defect (110) positioned within the structure to define a microcavity. The defect (110) includes a nonlinear material and being adapted to have an induced variation in index of refraction so as to tune the resonant mode of the microcavity.



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**TUNABLE MICROCAVITY USING NONLINEAR
MATERIALS IN A PHOTONIC CRYSTAL**

PRIORITY INFORMATION

5 This application claims priority from provisional application Ser. No. 60/032,723 filed December 13, 1996.

BACKGROUND OF THE INVENTION

10 The invention relates to photonic crystal tunable microcavities using nonlinear materials.

 The introduction of a local defect inside a perfect photonic crystal can generate sharp resonant states within the crystal in the vicinity of the defect. In this way, a photonic crystal can be used to fabricate a high-Q
15 microcavity. The frequency of the resonant modes depends on the size and shape of the defects, and on the refractive index of the materials used in the defect.

 Ordinarily, these defects are introduced during crystal fabrication by some mechanical process. Although the
20 frequency of the mode depends on the defect's size, shape, and index of refraction, mechanical alteration of the crystal is not a practical means of tuning the frequency after fabrication.

25 **SUMMARY OF THE INVENTION**

 Accordingly, the invention provides for the incorporation of a nonlinear dielectric material within a photonic crystal, as a means of changing the refractive index of the defect. In this way, the resonant frequency
30 can be easily adjusted, after fabrication, by external mechanisms (either optical or electronic). Since the ability to tune the frequency of a resonant mode is useful for constructing photonic integrated devices, the invention enables the use of a photonic-crystal microcavity for such
35 purposes.

 In one embodiment there is provided a photonic crystal having a periodic dielectric structure, and a defect positioned within the structure to define a microcavity.

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The defect includes a nonlinear material and being adapted to have an induced variation in index of refraction so as to tune the resonant mode of the microcavity.

5

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a perspective partially cut-away view of a three-dimensionally periodic dielectric tunable photonic crystal microcavity;

FIG. 2A is a top plan schematic view of an exemplary
10 two-dimensionally periodic dielectric tunable photonic crystal microcavity; FIG. 2B is an electric field distribution pattern of the resonant mode of the photonic crystal microcavity of FIG. 2A;

FIG. 3A is a top plan schematic view of an exemplary
15 one-dimensionally periodic dielectric tunable photonic crystal microcavity; FIG. 3B is a graph of the transmission spectrum through the photonic crystal microcavity normalized with respect to the incident intensity; FIG. 3C is an electric field pattern of the resonant mode of the photonic
20 crystal microcavity of FIG. 3A;

FIG. 4 is a plot of the frequency shift of the microcavity of FIG. 3A for the case where $\sigma=0.80$; and

FIG. 5 is a plot of the spectrum of the original and transmitted pulses with and without index variation in the
25 microcavity of FIG. 3A.

DETAILED DESCRIPTION OF THE ILLUSTRATED EMBODIMENTS

A photonic-crystal microcavity containing nonlinear materials can be used in a vast array of different types of
30 devices, including tunable filters, optical switches and gates, channel drop filters, and optical interconnects. Photonic crystals are particularly well suited for use in integrated devices because they have the ability to generate high-Q modes. Hence, only a small frequency modulation is
35 required to shift a mode over its entire width. This sensitive response is extremely important for an all optical device, because known optical materials are only slightly nonlinear. Photonic crystals can also generate modes that

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are strongly localized in space. The strong localization is important because the resonant frequency is controlled in a physically small space. Thus, it is possible to use this technique in a small device.

5 Most mechanisms used for changing the index of refraction rely on nonlinear effects such as the electro-optic effect, the charge carrier effect, or the photorefractive effect. In the microwave frequency regime, the nonlinearity of materials can be large. For example,
10 ferroelectric materials can generate index variations as large as or larger than 25% at or approximate to a frequency of 10 GHz. Typical examples of ferroelectric materials consist of BaTiO_3 and LiNbO_3 .

However, in the optical frequency regime (including
15 infrared), nonlinearities are smaller. Index changes are typically less than 0.1%. In spite of their small magnitudes, these index variations are sufficient for the invention. One particularly promising technique for varying the refractive index of a material at optical frequencies is
20 based on the photoionization of DX centers in certain compound semiconductors such as AlGaAs . The index variation occurs from the capture of electrons by positively charged donors. Each absorbed photon creates a pair of carriers, hence the index change increases linearly with local
25 illumination intensity. This process has the advantage of generating index variations larger than 10^{-3} , and may be used in the invention. Other techniques may also be useful for the invention, including the use of quantum well devices.

Defects can be fabricated in photonic crystals of any
30 dimensionality, for example, one dimension as described in U.S. Pat. No. 5,682,401 entitled "Resonant Microcavities Employing One Dimensionally Periodic Dielectric Waveguides", two dimensions as described in U.S. Pat. App. Ser. No. 08/395,441 entitled "Resonant Cavities Employing One-
35 dimensionally Periodic Dielectric Materials", or three dimensions as described in U.S. Pat. Nos. 5,440,421 and 5,600,483, both entitled "Three-dimensional Periodic Dielectric Structures Having Photonic Bandgaps", or with the

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use of metallodielectrics as described in U.S. Pat. App. Ser. No. 08/706,542 entitled "Metallodielectric Photonic Crystal", all of which are incorporated herein by reference. An exemplary embodiment for each dimension is presented 5 hereinafter.

FIG. 1 is a perspective view of an exemplary three-dimensionally periodic dielectric tunable photonic crystal microcavity 100 in accordance with the invention. The photonic crystal microcavity 100 is essentially a structure 10 made of a first material 102 having a first dielectric constant, preferably high index, and parallel rows along the illustrated x-axis of a second material 104, having a second dielectric constant, preferably low index, different than the first dielectric constant. According to an exemplary 15 embodiment, the first material is silicon or gallium arsenide and the second material is silicon dioxide or aluminum oxide, respectively.

The photonic crystal microcavity 100 also includes a series of parallel channels 106 or columns fabricated 20 through the structure in the illustrated z-axis for containing a third material 108 having a third dielectric constant (possibly equal to the second dielectric constant) which preferably has a large index contrast with the first dielectric constant. The use of air columns (dielectric 25 constant of 1) is preferred in order to provide the desired large index contrast between the different materials.

The photonic crystal microcavity 100 can be microfabricated by growing it layer by layer using conventional lithographic techniques. It is expected that 30 ten layers should be sufficient, although some applications may require a smaller or larger number of layers.

The introduction of a defect 110 inside the crystal structure can generate one or more sharp resonant modes in the vicinity of the defect. The defect can be made, for 35 example, by adding, removing, or changing some material inside the crystal during the growth sequence in one of the layers. In the photonic crystal microcavity 100 shown in FIG. 1, the defect 110 consists of a nonlinear material,

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such as erbium or aluminum gallium arsenide. The frequency of the resonant mode is tuned by varying the refractive index of the nonlinear material. This can be accomplished, for example, by sending current through or applying voltage across the crystal, or by shining light upon it.

A top plan schematic view of an exemplary two-dimensionally periodic dielectric tunable photonic crystal microcavity 200 is shown in FIG. 2A. The photonic crystal microcavity 200 consists of an array of dielectric rods 202 having a photonic bandgap. As in the three-dimensionally periodic crystal, a defect 204 can be introduced into the crystal structure by adding, removing, or changing some material. The defect can have any shape or size. In this specific embodiment, the radius of one rod is modified to be smaller than the remaining rods 202. By reducing or increasing the radius of the defect, localized modes appear inside the bandgap. It will be appreciated that other configurations of two-dimensionally periodic dielectric photonic crystals are disclosed in copending application Ser. No. 08/395,441.

FIG. 2B is an electric field distribution pattern of the resonant mode of the photonic crystal microcavity 200 for the case where the radius of the defect (rod 204) is reduced by half. The electric field is polarized along the axis of the rods. In this specific embodiment, every rod is made of nonlinear material. Since the mode is strongly confined, the index of refraction needs to be changed only in the vicinity of the defect in order to tune the frequency of the mode. Consequently, it would also have been possible to tune the frequency of the mode had only one or a few rods been made of nonlinear material in the vicinity of the defect.

In an alternative embodiment, the dielectric rods may be embedded in a dielectric material different than air. By choosing this material to be nonlinear, the tunability of the frequency of the modes can be enhanced.

It will be appreciated that the dielectric rods may be supported on a dielectric substrate or on dielectric stilts,

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or on a metallic plate or thin film. In addition, the rods can be positioned between dielectric layers or metallic plates. Alternatively, the two dimensionally periodic structure may be configured as an array of air or low index dielectric columns in a high dielectric material.

Next, the one-dimensional case is considered, such as a waveguide microcavity with a one-dimensionally periodic dielectric photonic crystal along the axis of the waveguide. FIG. 3A is a top plan schematic view of an exemplary one-dimensionally periodic dielectric tunable photonic crystal microcavity 300. In this specific embodiment, a plurality of holes 302 are etched into a waveguide 304 on either side of a defect 306. Because of its simplicity, this case is studied in more detail, computing the transmission along the waveguide by using a finite-difference time-domain computational method. The fundamental mode of the waveguide is excited at one end of the computational cell and propagates along the waveguide. The electric field is polarized in the plane of the waveguide.

FIG. 3B is a graph of the transmission spectrum through the photonic crystal microcavity 300 normalized with respect to the incident intensity. A wide gap can be seen between frequencies $f=0.21c/a$ and $f=0.32c/a$, and a sharp resonant mode appears inside the bandgap at frequency $f_0=0.25c/a$. The frequency is normalized with respect to a , where a is the distance between holes, center to center. By normalizing the frequency with respect to a , the results can be applied to any given lengthscale. In particular, in the case where the photonic crystal is operated at a wavelength of $1.55\mu\text{m}$, the outlined waveguide region 308 covers an area of approximately $1\mu\text{m}^2$.

FIG. 3C is an electric field pattern 310 of the resonant mode of photonic crystal microcavity 300. The mode is strongly confined in the vicinity of the defect and decays exponentially across the array of holes. The quality factor Q of the cavity, which is a measure of the total losses, is given by $f_0/\Delta f$ where f_0 is the resonant frequency and Δf is the full width at half-maximum of the resonator's

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Lorentzian response. In this particular case, the Q-factor is equal to 1300. Since the mode is strongly confined in the vicinity of the defect, only a small area of the photonic crystal needs to be affected to shift the resonance. If it is assumed that a fraction σ of the mode is located inside the dielectric material contained within the outlined region 308 in FIG. 3A, the frequency shift δf of the resonance will be approximated by

$$\delta f = \left[\frac{1}{1 + \frac{\sigma \delta n}{n}} - 1 \right] f_0 \quad (1)$$

for small changes of the index $\delta n/n$. The mode shown in FIG. 3C has approximately 80% of its electrical energy density inside the dielectric material.

FIG. 4 is a plot of Equation (1) for the case where $\sigma=0.80$. It will be appreciated that the frequency modulation is essentially linear over the entire range of $\delta n/n$. In order to resolve two peaks, the index variation should be sufficiently large to shift the resonance by at least one width, i.e., $\delta f > \Delta f$. Using Equation (1) along with the definition for Q, an expression for the minimum index change required to resolve two peaks is as follows:

20

$$\left| \frac{\delta n}{n} \right|_{\min} = \frac{1}{\sigma} \cdot \frac{1}{Q \pm 1} \approx \frac{1}{\sigma Q} \quad (2)$$

where the last part of the equation is valid for large values of Q. The \pm sign in the denominator corresponds to a negative (positive) index change. Other embodiments of the invention may require a smaller index change than the one defined in Equation (2).

For the photonic crystal microcavity 300, the magnitude of the minimum index variation to resolve two peaks is 1×10^{-3} , as computed from Equation (2). A variation of -3×10^{-3} is introduced and the transmission is investigated. In this specific embodiment, the index variation is generated only inside the dielectric material in the outlined region 308 in

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FIG. 3A. The spectrum of the transmitted pulse 500 is shown in the plot of FIG. 5 along with the spectrum of the unshifted pulse 502. The resonant frequency is shifted upward since the index variation is negative. The two curves in FIG. 5 are clearly resolved.

One salient example of the possibilities that this waveguide microcavity permits is the design of an all-optical switch. If the cavity mode is designed to be centered at a frequency $f_0 - \delta f$, and if a signal is transmitted at frequency f_0 , then the switch could be turned "on" by shifting the resonance to f_0 , and turned "off" by shifting it either back to $f_0 - \delta f$ or to $f_0 + \delta f$. Even if the resonance is shifted only part of this distance, the same device could be used as a modulator.

The switching speed is determined by the response time of the nonlinear material. In certain materials, the resonance may shift more quickly in one direction than in the other. To allow the switch to operate at the faster speed, one can place two microcavities in series. The first is initially in the "off" position, and the second is initially in the "on" position. To allow transmission, both cavities must be "on". This is accomplished by shifting the resonance of the first cavity upward. To turn the switch "off", the resonance of the second cavity is also shifted upward, but now with the effect of blocking the signal. Because it takes a longer time to reset the switch, this type of device is known as an on-off switch. Using DX-centers, the switch-on and switch-off times could be as short as one picosecond. Furthermore, the device would require an area of only a few μm^2 and less than 20 pJ of energy for switching.

In summary, a design of a tunable photonic crystal microcavity is presented which can be used in such devices as filters, modulators, switches, gates, channel drops, and interconnects. This microcavity can be fabricated in one-, two- or three-dimensionally periodic structures using nonlinear optical materials. It will be appreciated by those of skill in the art that while the invention has been

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described with respect to specific illustrated embodiments of one-, two-, and three-dimensionally periodic structures, other configurations with similar periodicity are possible.

5 The foregoing description has been set forth to illustrate the invention and is not intended to be limiting. Since modifications of the described embodiments incorporating the spirit and substance of the invention may occur to persons skilled in the art, the scope of the
10 invention should be limited solely with reference to the appended claims and equivalents thereof.

What is claimed is:

CLAIMS

- 1 1. A periodic structure comprising a defect positioned
2 within said structure to define a microcavity, said defect
3 comprising a nonlinear material and being adapted to have an
4 induced variation in index of refraction so as to tune the
5 resonant mode of said microcavity.
- 1 2. The structure of claim 1, wherein said structure
2 comprises one-dimensional periodicity.
- 1 3. The structure of claim 1, wherein said structure
2 comprises two-dimensional periodicity.
- 1 4. The structure of claim 1, wherein said structure
2 comprises three-dimensional periodicity.
- 1 5. The structure of claim 1, wherein the index of
2 refraction is varied in response to an applied current or
3 voltage to said nonlinear material.
- 1 6. The structure of claim 1, wherein the index of
2 refraction is varied in response to an applied
3 electromagnetic field to said nonlinear material.
- 1 7. The structure of claim 1, wherein the index of
2 refraction is varied in response to photoionization of DX
3 centers of said nonlinear material.
- 1 8. The structure of claim 1, wherein the frequency of
2 said resonant mode is varied in response to an applied
3 current or voltage.
- 1 9. The structure of claim 1, wherein the frequency of
2 said resonant mode is varied in response to an applied
3 electromagnetic field.
- 1 10. The structure of claim 1, wherein the frequency of

2 said resonant mode is varied in response to photoionization
3 of DX centers.

1 11. The structure of claim 1, wherein the frequency of
2 said resonant mode is in the optical regime.

1 12. The structure of claim 1, wherein the frequency of
2 said resonant mode is in the microwave regime.

1 13. The structure of claim 1, wherein said structure
2 comprises dielectric material.

1 14. The structure of claim 1, wherein said structure
2 comprises metallodielectric material.

1 15. A photonic crystal comprising:
2 a periodic structure; and
3 a defect positioned within said structure to define a
4 microcavity, said defect comprising a nonlinear material and
5 being adapted to have an induced variation in index of
6 refraction so as to tune the resonant mode of said
7 microcavity.

1 16. The photonic crystal of claim 15, wherein said
2 structure comprises one-dimensional periodicity.

1 17. The photonic crystal of claim 15, wherein said
2 structure comprises two-dimensional periodicity.

1 18. The photonic crystal of claim 15, wherein said
2 structure comprises three-dimensional periodicity.

1 19. The photonic crystal of claim 15, wherein the
2 index of refraction is varied in response to an applied
3 current or voltage to said nonlinear material.

1 20. The photonic crystal of claim 15, wherein the
2 index of refraction is varied in response to an applied

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3 electromagnetic field to said nonlinear material.

1 21. The photonic crystal of claim 15, wherein the
2 index of refraction is varied in response to photoionization
3 of DX centers of said nonlinear material.

1 22. The photonic crystal of claim 15, wherein the
2 frequency of said resonant mode is varied in response to an
3 applied current or voltage.

1 23. The photonic crystal of claim 15, wherein the
2 frequency of said resonant mode is varied in response to an
3 applied electromagnetic field.

1 24. The photonic crystal of claim 15, wherein the
2 frequency of said resonant mode is varied in response to
3 photoionization of DX centers.

1 25. The photonic crystal of claim 15, wherein the
2 frequency of said resonant mode is in the optical regime.

1 26. The photonic crystal of claim 15, wherein the
2 frequency of said resonant mode is in the microwave regime.

1 27. The photonic crystal of claim 15, wherein said
2 structure comprises dielectric material.

1 28. The photonic crystal of claim 15, wherein said
2 structure comprises metallodielectric material.

1 29. A tunable photonic crystal microcavity comprising:
2 a periodic dielectric photonic crystal structure; and
3 a defect positioned within said structure, said defect
4 comprising a nonlinear material, wherein
5 said microcavity exhibits a resonant mode which is
6 tuned by varying the index of refraction of said nonlinear
7 material.

1 30. The microcavity of claim 29, wherein said
2 structure comprises one-dimensional periodicity.

1 31. The microcavity of claim 29, wherein said
2 structure comprises two-dimensional periodicity.

1 32. The microcavity of claim 29, wherein said
2 structure comprises three-dimensional periodicity.

1 33. The microcavity of claim 29, wherein the index of
2 refraction is varied in response to an applied current or
3 voltage to said nonlinear material.

1 34. The microcavity of claim 29, wherein the index of
2 refraction is varied in response to an applied
3 electromagnetic field to said nonlinear material.

1 35. The microcavity of claim 29, wherein the index of
2 refraction is varied in response to photoionization of DX
3 centers of said nonlinear material.

1 36. The microcavity of claim 29, wherein the frequency
2 of said resonant mode is varied in response to an applied
3 current or voltage.

1 37. The microcavity of claim 29, wherein the frequency
2 of said resonant mode is varied in response to an applied
3 electromagnetic field.

1 38. The microcavity of claim 29, wherein the frequency
2 of said resonant mode is varied in response to
3 photoionization of DX centers.

1 39. The microcavity of claim 29, wherein the frequency
2 of said resonant mode is in the optical regime.

1 40. The microcavity of claim 29, wherein the frequency
2 of said resonant mode is in the microwave regime.

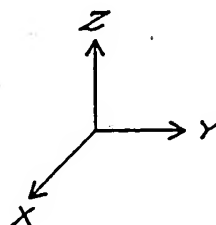
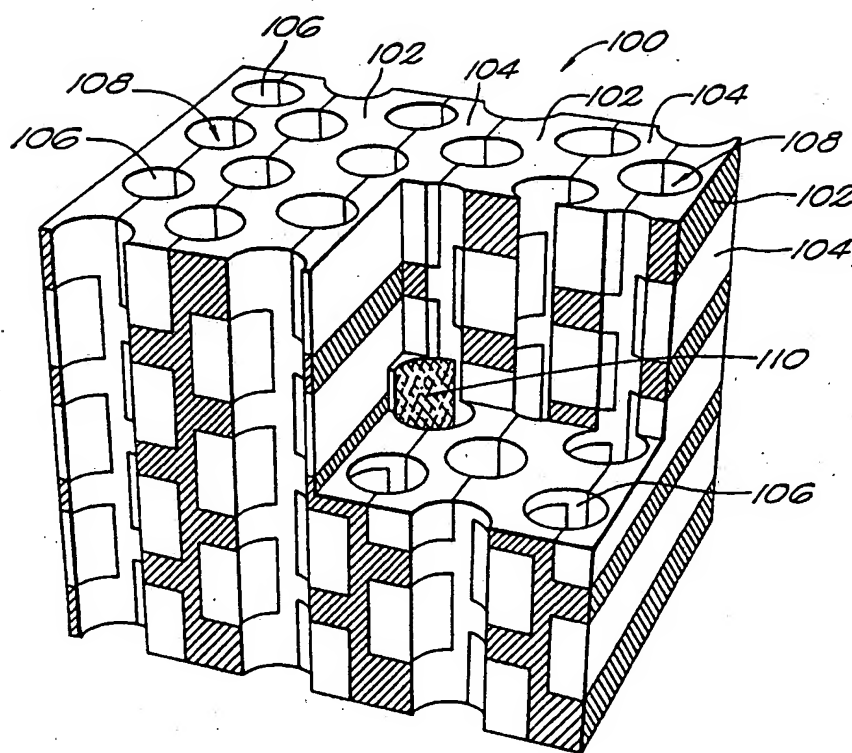
1 41. The microcavity of claim 29, wherein said
2 structure comprises dielectric material.

1 42. The microcavity of claim 29, wherein said
2 structure comprises metallodielectric material.

1 43. A method of tuning a photonic crystal comprising:
2 providing a dielectric periodic structure, said
3 structure having a defect positioned to define a microcavity
4 with a resonant mode, said defect comprising a nonlinear
5 material;
6 varying the index of refraction of said nonlinear
7 material to the resonant mode of said microcavity.

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FIG. 1



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**FIG.
2A**

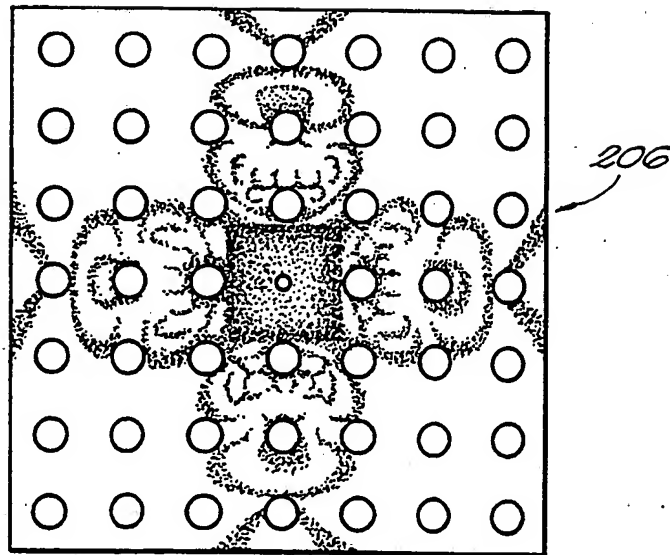
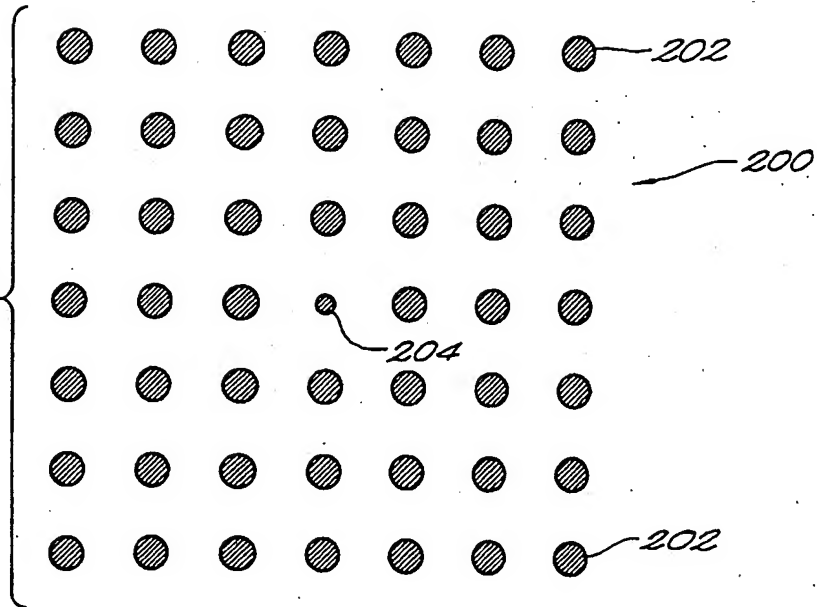
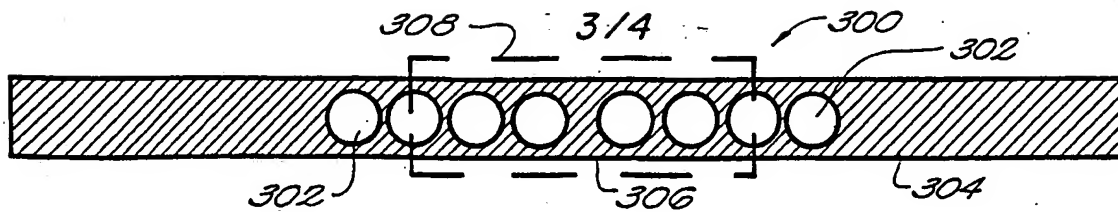
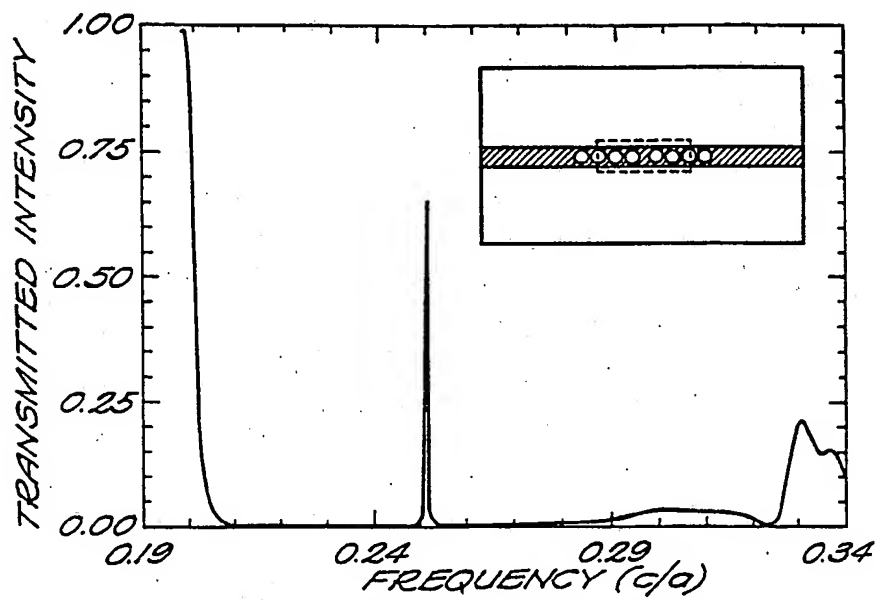
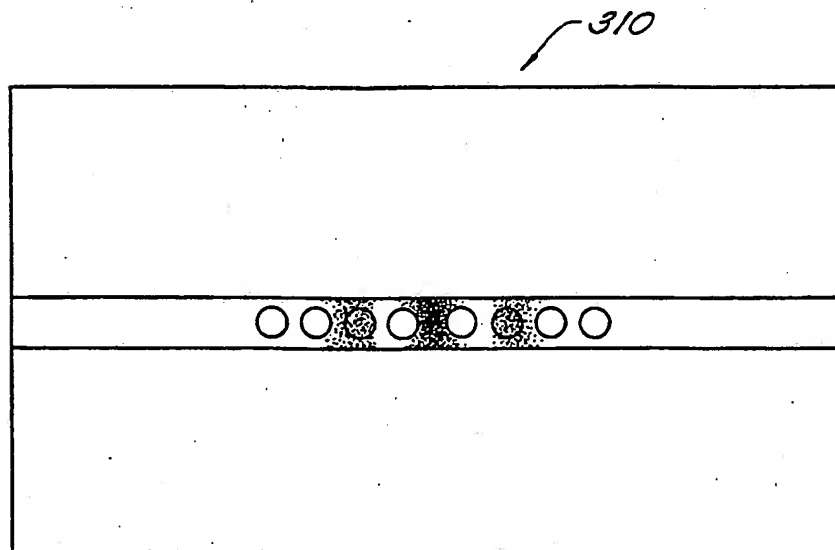
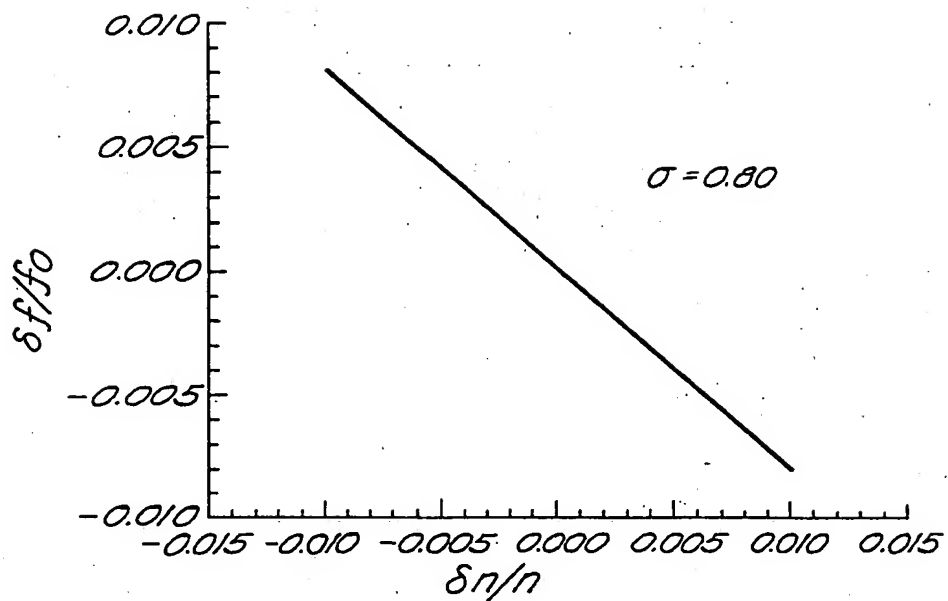
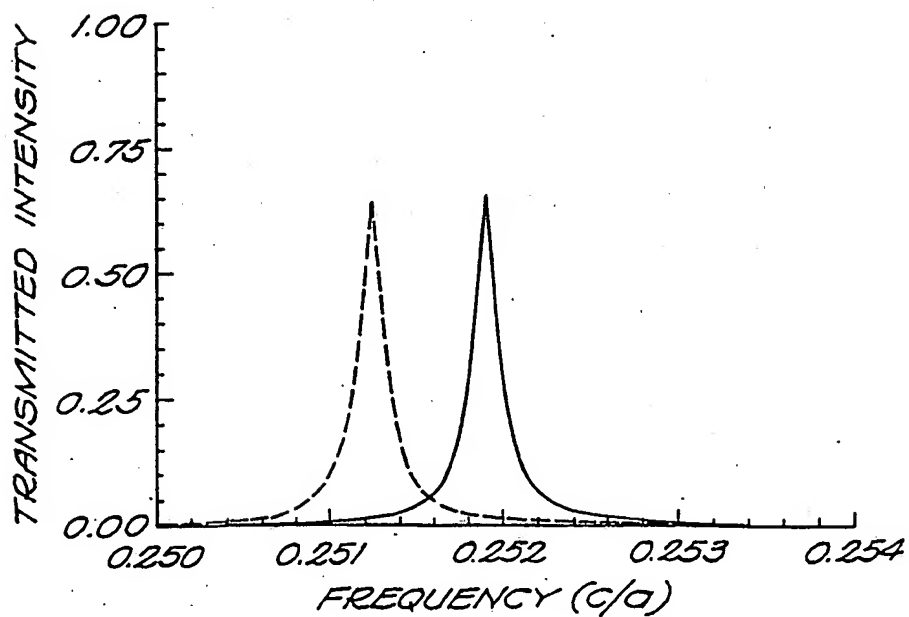


FIG. 2B

**FIG. 3A****FIG. 3B****FIG. 3C**

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**FIG. 4****FIG. 5**

INTERNATIONAL SEARCH REPORT

International Application No.

PCT/US 97/22786

A. CLASSIFICATION OF SUBJECT MATTER

IPC 6 G02B6/122 G02B6/124 G02F1/35

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC 6 G02B G02F

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	WO 96 27225 A (MASSACHUSETTS INST TECHNOLOGY) 6 September 1996 cited in the application see page 5, line 6 - line 38 see page 6 - page 7 see figures	1, 15, 29, 43
A	idem	3, 4, 11-13, 17, 18, 25-27, 31, 32, 39-41
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☒ Further documents are listed in the continuation of box C.

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Date of the actual completion of the international search

22 April 1998

Date of mailing of the international search report

08/05/1998

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INTERNATIONAL SEARCH REPORT

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C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	<p>MCGURN A R: "Green's-function theory for row and periodic defect arrays in photonic band structures"</p> <p>PHYSICAL REVIEW, B. CONDENSED MATTER., vol. 53, no. 11, 15 March 1996, NEW YORK US,</p> <p>pages 7059-7064, XP002063055</p> <p>see page 7059</p> <p>see page 7060 left column line 1-32</p> <p>see page 7064</p> <p style="text-align: center;">---</p>	<p>1,15,29, 43</p>
A	<p>US 5 245 466 A (BURNS MICHAEL M ET AL) 14 September 1993</p> <p style="text-align: center;">---</p> <p>see claims; figure 1</p> <p style="text-align: center;">---</p>	<p>1,6,9, 11,13, 15,20, 23,25, 27-29, 34,37, 39,41-43</p>
A	<p>WO 96 29621 A (MASSACHUSETTS INST TECHNOLOGY) 26 September 1996</p> <p>cited in the application</p> <p style="text-align: center;">---</p> <p>see page 6, line 8 - line 33</p> <p>see page 7 - page 9</p> <p>see claims; figures 1-3</p> <p style="text-align: center;">---</p>	<p>1,3,4, 11-14, 16-18, 25-28, 31-33, 40,41</p>
A	<p>KOOPS H W P: "PHOTONIC CRYSTALS BUILT BY THREE-DIMENSIONAL ADDITIVE LITHOGRAPHY ENABLE INTEGRATED OPTICS OF HIGH DENSITY"</p> <p>PROCEEDINGS OF THE SPIE, vol. 2849, 5 August 1996, pages 248-256, XP000617864</p> <p style="text-align: center;">---</p> <p>see the whole document</p> <p style="text-align: center;">---</p>	<p>1-5,8, 11-13, 16-19, 22, 25-27, 29-33, 36, 39-41,43</p>
A	<p>US 5 452 123 A (ASHER SANFORD A ET AL) 19 September 1995</p> <p style="text-align: center;">---</p> <p>see column 6, line 34 - line 68</p> <p>see column 7 - column 8</p> <p>see column 9, line 1 - line 66</p> <p>see figures 1-3</p> <p style="text-align: center;">---</p> <p style="text-align: center;">-/--</p>	<p>1,3,6,9, 11,13, 15,18, 20,23, 25,27, 29,32, 34,37, 39,41,43</p>

INTERNATIONAL SEARCH REPORT

International Application No

PCT/US 97/22786

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	<p>VILLENEUVE P R ET AL: "PHOTONIC BANDGAPS IN PERIODIC DIELECTRIC STRUCTURES" PROGRESS IN QUANTUM ELECTRONICS, vol. 18, no. 2, 1 January 1994, pages 153-200, XP000562379</p> <p>see page 179 - page 186 see page 194 - page 197 -----</p>	<p>1-4, 11-13, 15-18, 25-27, 29-32, 39,40,43</p>

INTERNATIONAL SEARCH REPORT

Information on patent family members

International Application No

PCT/US 97/22786

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
WO 9627225 A	06-09-1996	NONE	
US 5245466 A	14-09-1993	NONE	
WO 9629621 A	26-09-1996	NONE	
US 5452123 A	19-09-1995	US 5737102 A	07-04-1998